

Notice of References Cited

Application/Control No.

10/535,406

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

RANDAL WILLIS

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0149598	10-2002	Greier et al.	345/589
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NON-PATENT DOCUMENTS

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